HUMBER ENGINEERING

MENG-3020 SYSTEMS MODELING & SIMULATION

LECTURE 11





LECTURE 11 Model Validation Methods

- Simulation and Cross-Validation
 - Prediction Error Method
- Model Validity Criterion
 - Akaike's Final Prediction Error (FPE)
 - Mean-Squares Error (MSE)
 - Parameters Confidence Intervals
- Pole-Zero Plots
- Residual Analysis

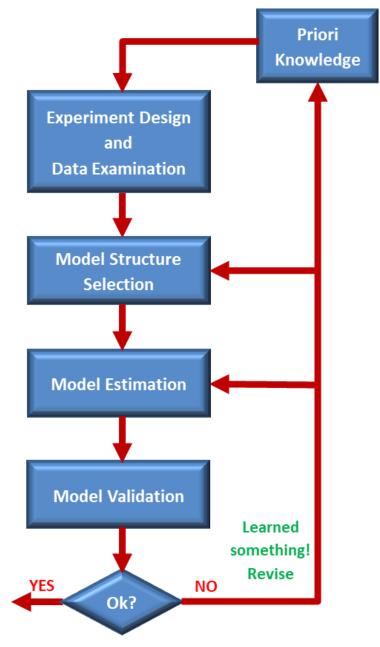
System Identification Procedure

■ Model Validation Techniques

 The procedures that asses the quality of a model are generally called Model Validation techniques.



- **Simulation & Cross Validation**
 - Prediction Error Method
- Model Validity Criteria
 - Parameters Confidence Intervals
 - Final Prediction Error (FPE)
 - Mean-squared Error (MSE)
- Pole-Zero Plots
- Residual Analysis
 - Whiteness Test
 - Independency Test



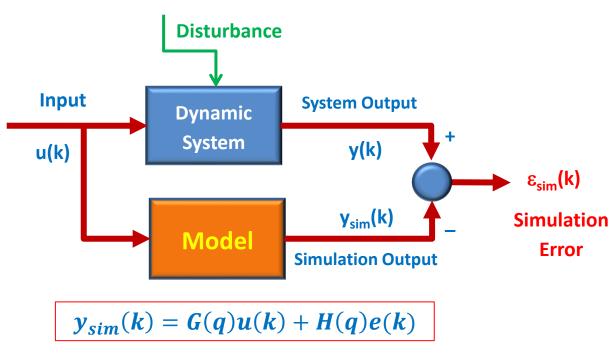
• Simulation and Cross-Validation are methods for testing whether a model can reproduce the observed output data when driven by the actual input.

□ Simulation

• In simulation test we compare the desired model output (= system output), y(k), with the simulated output by the model, $y_{sim}(k)$, and we only observe how much the plots of y(k) and $y_{sim}(k)$ differ.

Simulation Error
$$\rightarrow \varepsilon_{sim}(k) = y(k) - y_{sim}(k)$$

- In Simulation Test, there is a risk of over-fitting the data in noisy systems.
- Since over-fitting leads to a small simulation error, however, this does not mean that the model is accurate.
- To avoid the over-fitting issue the Cross-validation method is advised.



■ MATLAB Function for Simulation

The Simulation approach can be applied by command sim in MATLAB

Variable	Description
ysim	Simulated response
sys	Estimated or constructed dynamic system model
data	Identification data

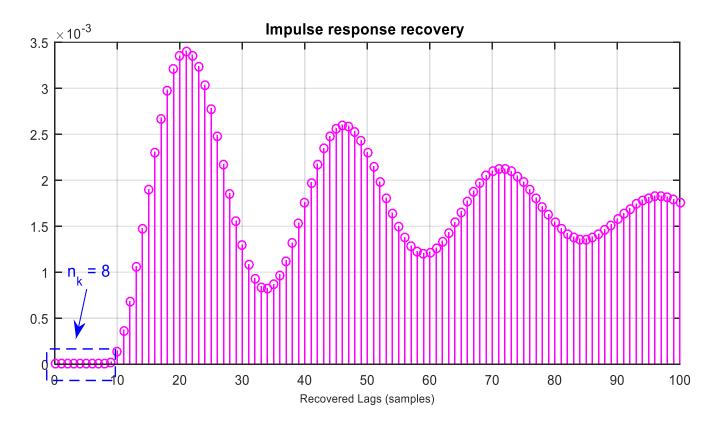
• sim returns the simulated response of an identified model sys based on the given identification data.



Assume that the collected noise-free input-output data is available with N=500, $T_s=0.05 {\rm sec.}$

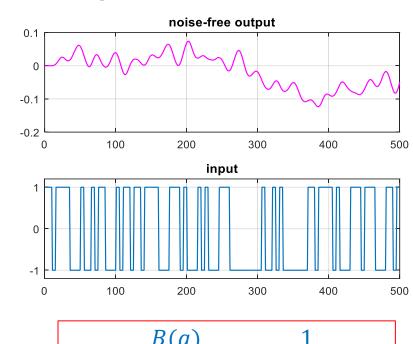
$$\{u(k), y(k) | k = 1, \dots, N\}$$

The impulse response coefficients are recovered as below



Assume that the system is identified by an ARX model structure

$$[n_a \qquad n_b \qquad n_k] = [3 \quad 3 \quad 8]$$

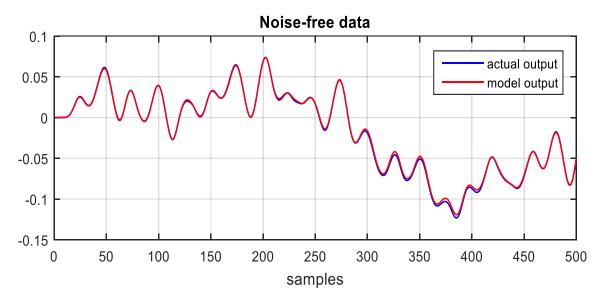




Assume that the collected noise-free input-output data is available with N=500, $T_s=0.05 {\rm sec.}$

$$\{u(k), y(k) | k = 1, \dots, N\}$$

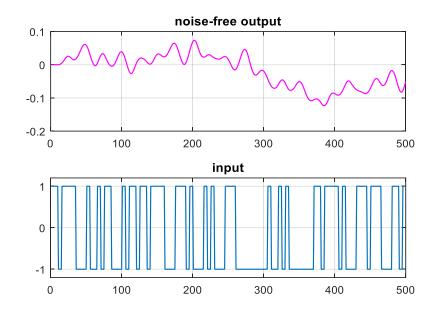
The identified model can be tested with the I/O data in a simulation using the sim function in MATLAB:



In noise-free case, we can easily compare the actual system output and the model output via simulation visually.

$$\varepsilon_{sim}(k) = y(k) - y_{sim}(k) \rightarrow \|\varepsilon_{sim}(k)\| = 0.0359$$

Since the simulation error is small the results are acceptable for noise-free data.



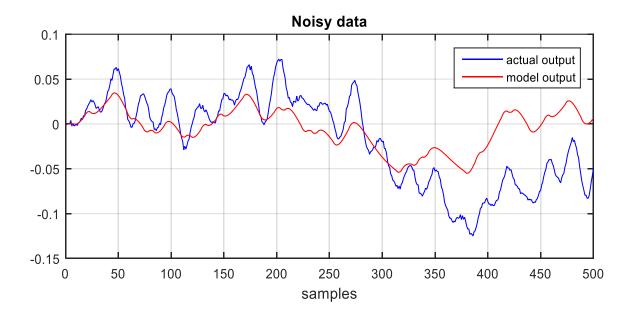
```
data = iddata(y,u,Ts);
na = 3;
nb = 3;
nk = 8;
M ARX = arx(data,[na nb nk]);
ysim = sim(data,M ARX);
plot([y ysim])
e sim = norm(y-ysim);
```



Assume that the collected noise-free input-output data is available with N=500, $T_s=0.05 {\rm sec.}$

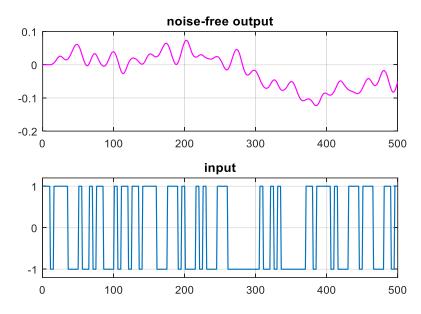
$$\{u(k), y(k) | k = 1, \dots, N\}$$

Assume that additive white noise is added to output signal with SNR=30dB. Then, the system is identified by noisy data set and tested with the I/O data in a simulation by using the sim function in MATLAB:



 In <u>noisy</u> case, the <u>simulation error</u> between the actual output and the model output is greater than the <u>noise-free</u> case.

$$\varepsilon_{sim}(k) = y(k) - y_{sim}(k) \rightarrow \|\varepsilon_{sim}(k)\| = 0.9196$$



```
SNR = 30;
yn = awgn(y,SNR,'measured');
datan = iddata(yn,u,Ts);
na = 3;
nb = 3;
nk = 8;
M_ARXwn = arx(datan,[na nb nk]);

ynsim = sim(datan,M_ARXwn);
plot([yn ynsim])
e_sim = norm(yn-ynsim);
```



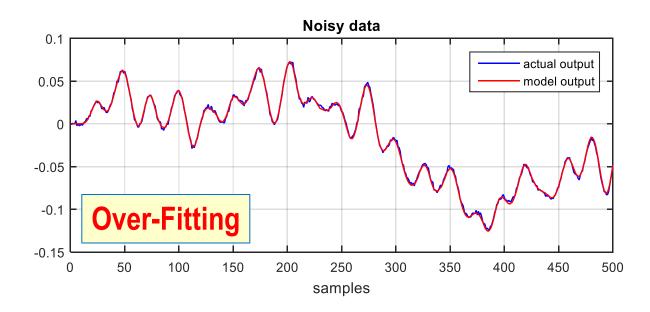
Assume that the collected noise-free input-output data is available with N=500, $T_{\rm S}=0.05{\rm sec}$.

$$\{u(k), y(k) | k = 1, \dots, N\}$$

In noisy cases, usually increasing the model order decreases the simulation error. However, it leads to **over-fitting** the data.

• For example, by considering the following ARX structure the simulation error between model output and actual output decreases.

$$[n_a \quad n_b \quad n_k] = [15 \quad 15 \quad 8]$$



$$\varepsilon_{sim}(k) = y(k) - y_{sim}(k) \rightarrow \|\varepsilon_{sim}(k)\| = 0.0431$$

```
noise-free output

0.1

0
-0.1

-0.2

0 100 200 300 400 500

input

1
0
-1
0 100 200 300 400 500
```

```
SNR = 30;
yn = awgn(y,SNR,'measured');
datan = iddata(yn,u,Ts);
na = 15;
nb = 15;
nk = 8;
M_ARXwn = arx(datan,[na nb nk]);

ynsim = sim(datan,M_ARXwn);
plot([yn ynsim])
e_sim = norm(yn-ynsim);
```

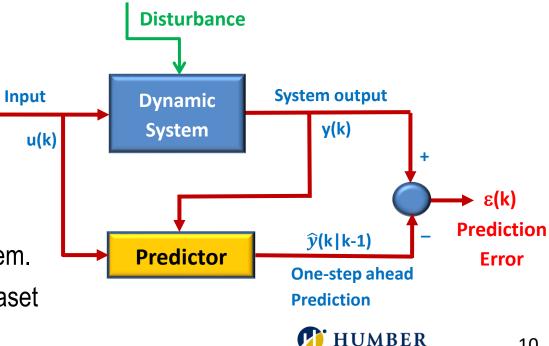
□ Cross-Validation

- Cross-validation is the procedure that compares the quality of identified models by validating them on a dataset where neither of them was estimated.
- In cross-validation method we split the I/O dataset Z in two subset:
 - Identification data $(Z_{id}) \rightarrow To$ compute the optimal parameters θ
 - Validation data $(Z_{val}) \rightarrow$ To check how the estimated model behaves on fresh data
- The validation criteria is defined based on minimizing the error between the desired model output (= system output) y(k) and the one-step ahead predicted output $\hat{y}(k|k-1)$ for the estimated parameters θ by using the validation dataset.

One-step ahead Prediction Error $\rightarrow \ \ arepsilon(k) = y(k) - \widehat{y}(k|k-1)$

$$J(\theta, Z_{val}) = \frac{1}{N_{val}} \sum_{k=1}^{N_{val}} (y(k) - \hat{y}(k|k-1))^2$$

- No need to apply any statistical arguments and assumption about the system.
- Needs to save a fresh dataset for validation, and we cannot use all the dataset to identification.



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■ MATLAB Function for Cross-Validation

Cross-validation approach can be applied by command compare in MATLAB

compare(data,sys,kstep)

Variable	Description
sys	Estimated or constructed dynamic system model
data	Validation data
kstep	prediction horizon (default = 0)

- **compare** function plots the simulated (or predicted) response of a dynamic system model **sys** and superimposed over the validation data, **data**, for comparison.
- The plot also displays the Normalized Root Mean Square (NRMSE) measure of the goodness of the fit.



Assume the collected noisy input-output data from Example 1 with N=500, $T_s=0.05 \mathrm{sec}$.

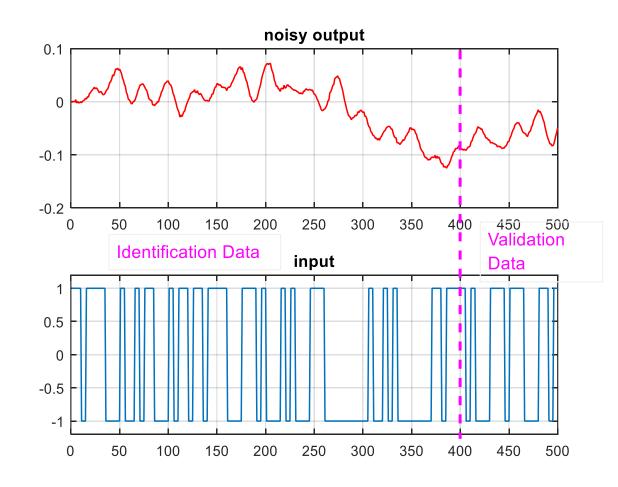
$$\{u(k), y(k) | k = 1, \dots, N\}$$

Here, we have N = 500 samples of I/O data. The first 400 samples are used for identification (estimation the model parameters), the rest of the data for validation.

$$N_{id} = 400, \qquad N_{val} = 100$$

```
datawn = iddata(yn,u,Ts);
datawni = datawn(1:400);
datawnv = datawn(401:N);
```

First, we identify the system by using the identification data and then validate the model by using the validation data and minimizing the one-step ahead prediction error.

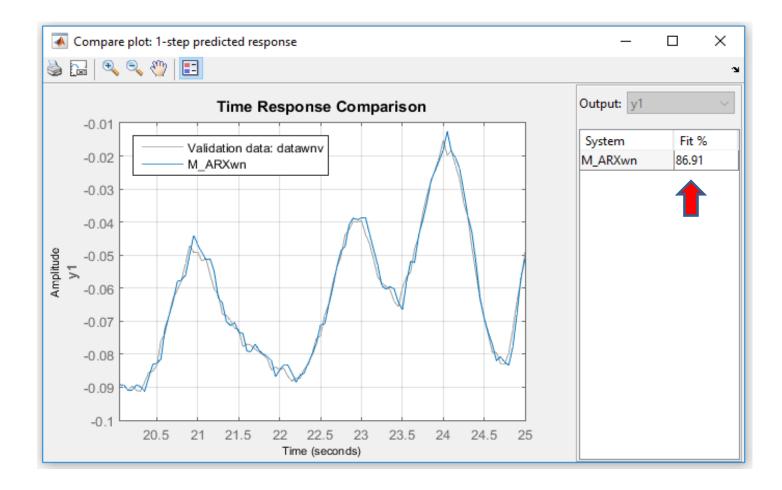




Assume the collected noisy input-output data from Example 1 with N=500, $T_{\rm S}=0.05{\rm sec.}$

 $\{u(k), y(k) | k = 1, \dots, N\}$

Case 1: ARX(3,3,8) Model Structure



0.1
-0.2
0 50 100 150 200 250 300 350 400 450 500
Validation
Data

1
0.5
-1
0 50 100 150 200 250 300 350 400 450 500

```
datawn = iddata(yn,u,Ts);
datawni = datawn(1:400);
datawnv = datawn(401:N);
```

```
na = 3;
nb = 3;
nk = 8;
M_ARXwn = arx(datawni,[na nb nk]);
compare(datawnv,M_ARXwn,1)
```

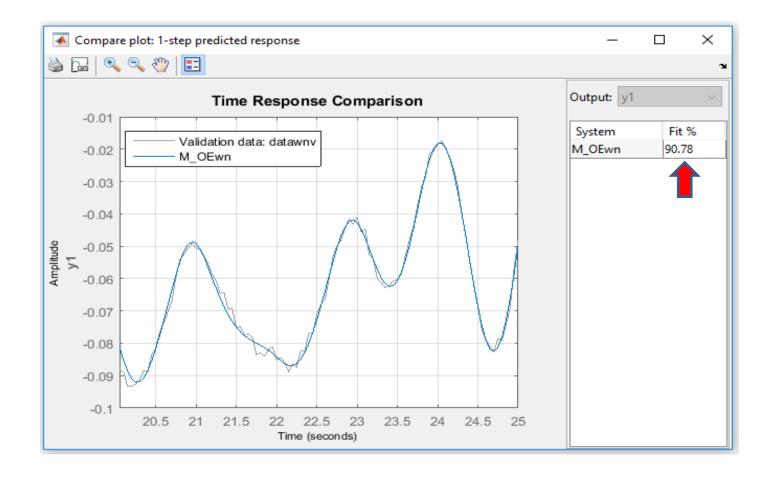
The results show that using the Cross-validation method to validate the ARX(3,3,8) model gives better result (86.91% fit) without increasing the model order and no over-fitting issue.

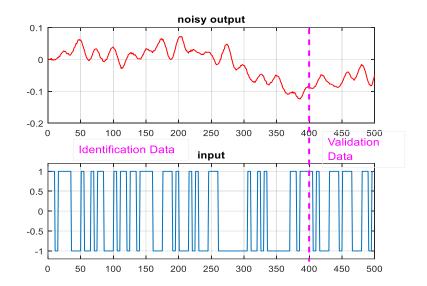


Assume the collected noisy input-output data from Example 1 with N=500, $T_S=0.05 {\rm sec.}$

 $\{u(k), y(k) | k = 1, \dots, N\}$

Case 2: OE(3,3,8) Model Structure



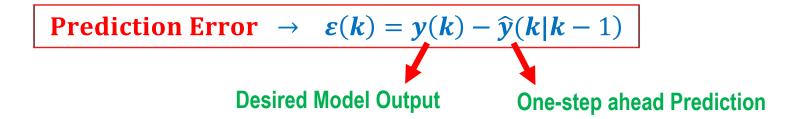


```
datawn = iddata(yn,u,Ts);
datawni = datawn(1:400);
datawnv = datawn(401:N);
```

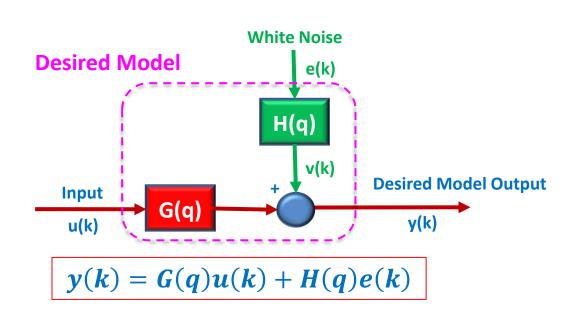
```
nb = 3;
nf = 3;
nk = 8;
M_OEwn = oe(datawni,[nb nf nk]);
compare(datawnv,M_OEwn,1)
```

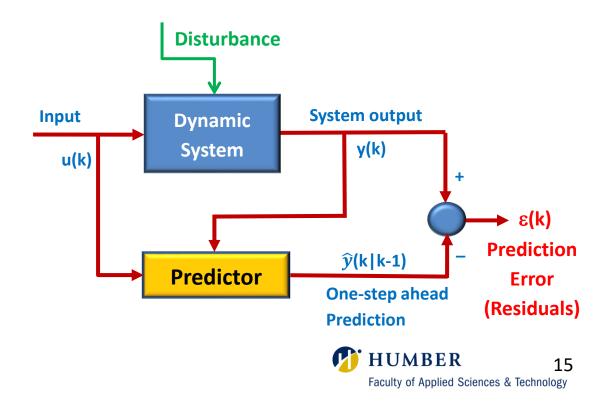
The results show that the OE(3,3,8) model gives better result (90.78% fit) than the ARX(3,3,8) model (86.91% fit). This is because the noise is the Additive White Noise not process noise.

- In Prediction Error Methods, we use a predictor to measure the performance of the corresponding model.
- The Prediction Error (or Residuals) is defined as the difference between the system output (= desired model output) y(k) and the one-step ahead predicted output $\hat{y}(k|k-1)$ for the estimated parameters θ .



The goal is to determine an <u>optimal predictor</u> such that the prediction error is minimized.





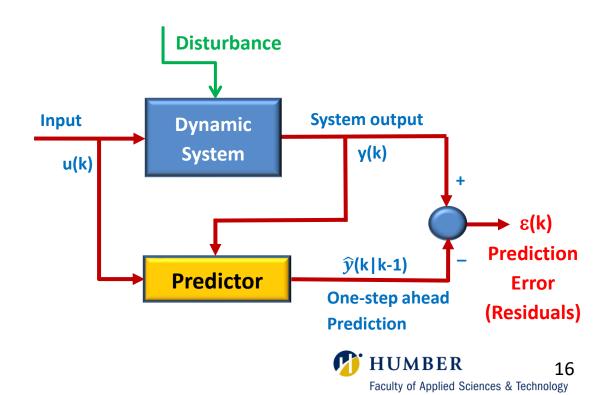
Optimal Predictor

The predictor can be defined as the linear combination of the past input-output data:

$$\begin{split} \widehat{y}(k|k-1) &= s_0 u(k) + s_1 u(k-1) + \dots + s_{n_s} u(k-n_s) + t_1 y(k-1) + t_2 y(k-2) + \dots + t_{n_t} y(k-n_t) \\ \widehat{y}(k|k-1) &= (s_0 + s_1 q^{-1} + s_2 q^{-2} + \dots + s_{n_s} q^{-n_s}) u(k) + (t_1 q^{-1} + t_2 q^{-2} + \dots + t_{n_t} q^{-n_t}) y(k) \end{split}$$
 Predictor
$$\widehat{y}(k|k-1) &= S(q) u(k) + T(q) y(k)$$

• Since only the output, y(k), is disturbed by noise, the term S(q)u(k) contains information about the deterministic part of the predictor and term T(q)y(k) introduces a stochastic component into the predictor.

What are the optimal filters for S(q) and T(q) to achieve the minimum prediction error?



Optimal Predictor

The predictor can be defined as the linear combination of the past input-output data:

Predictor
$$\widehat{y}(k|k-1) = S(q)u(k) + T(q)y(k)$$

The optimal predictor is achievable if the difference between the output y(k) and the predicted output $\hat{y}(k|k-1)$ is equal to the White Noise e(k)

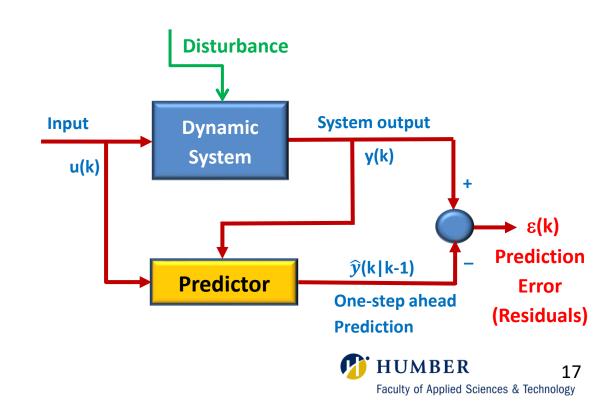
Optimal Predictor Condition
$$\varepsilon(k) = y(k) - \widehat{y}(k|k-1) = e(k) =$$
White Noise

The optimal predictor can be determined as below:

$$y(k) = G(q)u(k) + H(q)e(k)$$
$$y(k) = G(q)u(k) + H(q)[y(k) - \hat{y}(k|k-1)]$$

Optimal Predictor
$$\widehat{y}(k|k-1) = \frac{G(q)}{H(q)}u(k) + \left[1 - \frac{1}{H(q)}\right]y(k)$$

$$S(q) \qquad T(q)$$



We can determine the optimal predictor for different model structures.

$$\widehat{y}(k|k-1) = \frac{G(q)}{H(q)}u(k) + \left[1 - \frac{1}{H(q)}\right]y(k)$$

Optimal Predictor of ARX Model

$$y(k) = \frac{B(q)}{A(q)}u(k) + \frac{1}{A(q)}e(k)$$

Optimal ARX Predictor

$$\widehat{y}(k|k-1) = B(q)u(k) + [1 - A(q)]y(k)$$

Optimal Predictor of OE Model

$$y(k) = \frac{B(q)}{F(q)}u(k) + e(k)$$

Optimal OE Predictor

$$\widehat{y}(k|k-1) = \frac{B(q)}{C(q)}u(k)$$

Optimal Predictor of BJ Model

$$y(k) = \frac{B(q)}{F(q)}u(k) + \frac{C(q)}{D(q)}e(k)$$

Optimal BJ Predictor

$$\widehat{y}(k|k-1) = \frac{B(q)D(q)}{F(q)C(q)}u(k) + \left[1 - \frac{D(q)}{C(q)}\right]y(k)$$

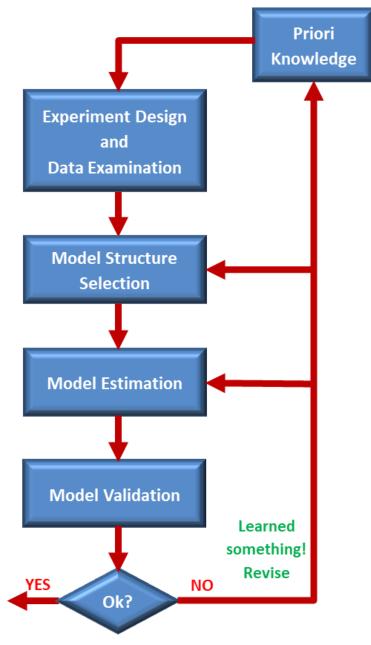
System Identification Procedure

Model Validation Techniques

- The procedures that asses the quality of a model are generally called Model Validation techniques.
 - **Simulation & Cross Validation**
 - **Prediction Error Method**



- **Model Validity Criteria**
 - Parameters Confidence Intervals
 - Final Prediction Error (FPE)
 - Mean-squared Error (MSE)
- **Pole-Zero Plots**
- **Residual Analysis**
 - Whiteness Test
 - Independency Test



Accept the model

- It is possible to determine the suitable model order by studying some criteria, which depend on the model order.
- Some of such criteria are:
 - Mean-squared Error (MSE)
 - Akaike's Final Prediction Error (FPE)
 - Percentage of the Fit to Estimated Data
 - Parameters Confidence Intervals
- The model validity criteria are given by command present in MATLAB.

Variable	Description
sys	Estimated or constructed dynamic system model

- These criteria are indices that represent goodness of the fit presented by the model.
- The smaller the indices, the better the result.



Assume the collected noisy input-output data from Example 1 with N=500, $T_S=0.05 {\rm sec.}$

$$\{u(k), y(k) | k = 1, \dots, N\}$$

Here, we selected ARX(3,3,8) model structure. Now, we want to calculate the <u>model validity criteria</u> of the model using the <u>present</u> function in MATLAB.

```
y(k) = \frac{B(q)}{A(q)}u(k) + \frac{1}{A(q)}e(k)
```

```
M_ARXwn =
Discrete-time ARX model: A(z)y(t) = B(z)u(t) + e(t)

A(z) = 1 - 1.24 (+/- 0.04436) z^-1 - 0.2424 (+/- 0.07659) z^-2 + 0.4907 (+/- 0.04394) z^-3

B(z) = -0.0003379 (+/- 0.000279) z^-8 + 0.0004769 (+/- 0.0003742) z^-9 + 0.0004133 (+/- 0.0002829) z^-10

Status:

Fit to estimation data: 93.44% (prediction focus)

FPE: 9.955e-06

MSE: 9.873e-06
```

□ Parameters Confidence Intervals

- The standard deviation of the estimated parameters, which has to be a small value.
- When the parameter confidence intervals are large, it means that:
 - There is a large variance in the estimation
 - The model orders have been chosen too large
 - The number of data points is too small

```
M_ARXwn =
Discrete-time ARX model: A(z)y(t) = B(z)u(t) + e(t)

A(z) = 1 - 1.24 (+/- 0.04436) z^-1 - 0.2424 (+/- 0.07659) z^-2 + 0.4907 (+/- 0.04394) z^-3

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Status:

Fit to estimation data: 93.44% (prediction focus)

FPE: 9.955e-06

MSE: 9.873e-06
```

Percentage of the Fit to Estimated Data

The Normalized Root Mean-Squared Error (NRMSE) expressed as a percentage, where:

```
Fit Percentage = \left(1 - \frac{\|y - y_m\|}{\|y - \overline{y}\|}\right) \times 100\%
```

```
y: the measured output data,
\bar{y}: the mean value of y,
y_m: the simulated or predicted response of the model
```

High percent of fit not necessarily represents the good model, it might be result of over-fitting or over-parametrizing. The other criteria FPF and MSF must also be considered

```
M ARXwn =
Discrete-time ARX model: A(z)y(t) = B(z)u(t) + e(t)
A(z) = 1 - 1.24 (+/-0.04436) z^{-1} - 0.2424 (+/-0.07659) z^{-2} + 0.4907 (+/-0.04394) z^{-3}
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Status:
Fit to estimation data: 93.44% (prediction focus)
FPE: 9.955e-06
MSE: 9.873e-06
```

Mean-Squared Error (MSE)

- Mean-squared Error measure is defined as:
 - This criterion is an estimate of the prediction error variance, which shows the model accuracy.
 - MSE is the loss function to be minimized for SISO models.
 - Small MSE value indicates small prediction error for this estimated model.

```
MSE = \frac{1}{N} \sum_{k=1}^{N} \varepsilon^{2}(k)
```

```
M_ARXwn =
Discrete-time ARX model: A(z)y(t) = B(z)u(t) + e(t)

A(z) = 1 - 1.24 (+/- 0.04436) z^-1 - 0.2424 (+/- 0.07659) z^-2 + 0.4907 (+/- 0.04394) z^-3

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Status:

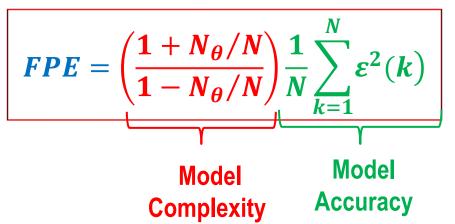
Fit to estimation data: 93.44% (prediction focus)

FPE: 9.955e-06

MSE: 9.873e-06
```

☐ Final Prediction Error (FPE)

- The Final Prediction Error (FPE) criterion proposes to choose the model set that achieves a minimum value for the following expression:
- Here, N_{θ} is the number of parameters in the model set.
- This criterion has two terms:
 - To describe the model accuracy → Loss Function
 - To describe model complexity → Penalizing term to avoid over-fitting



- The Model Accuracy part is basically the loss function. In FPE the loss function is penalized by the model complexity term to avoid the over-fitting issues.
- Therefore, by comparing models using these criteria, we can pick a model that gives the best trade-off between the accuracy and the complexity.

```
Status:

Fit to estimation data: 93.44% (prediction focus)

FPE: 9.955e-06

MSE: 9.873e-06
```

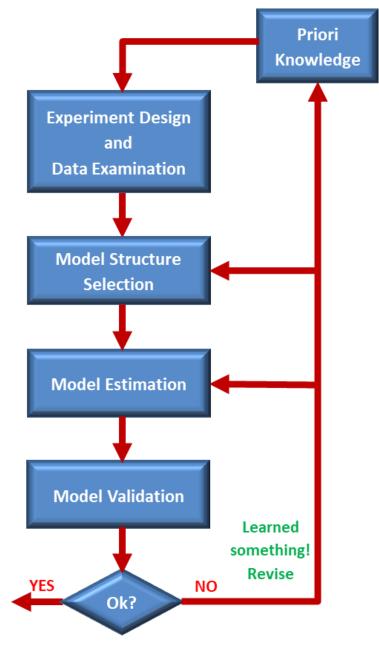
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 - Simulation & Cross Validation
 - Prediction Error Method
 - Model Validity Criteria
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 - Mean-squared Error (MSE)



- Pole-Zero Plots
- Residual Analysis
 - Whiteness Test
 - Independency Test



Pole-Zero Plots

- The Pole/Zero Plot helps to model reduction, if there is a sign of pole-zero cancellation in an over-parameterized model.
- If there are sign of pole-zero cancellation for model order higher than a certain value p, it means that a suitable model order n has to be selected as $n \le p$.
- Over-parameterization makes the model unnecessarily complicated and be sensitive to parameter variations.
- Over-parameterization may result an over-fitted model, but these two terms are not same.
 - Over-fitting occurs when the model starts fitting the noise.
 - Over-parameterization occurs when the model order selected higher unnecessarily even in noise-free case.
- The Pole/Zero Plot is obtained by command pzmap in MATLAB.

pzmap(sys)

Variable	Description
sys	CT or DT dynamic system model

Pole-Zero Plots



Assume the collected noise-free input-output data from Example 2 with N=500, $T_{\rm S}=0.05{\rm sec}$,

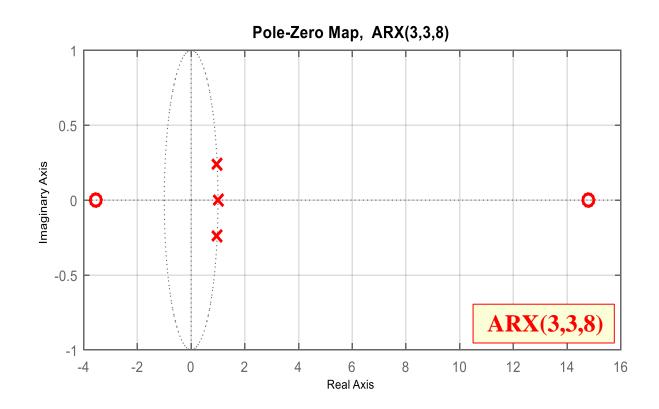
$$\{u(k), y(k) | k = 1, \dots, N\}$$

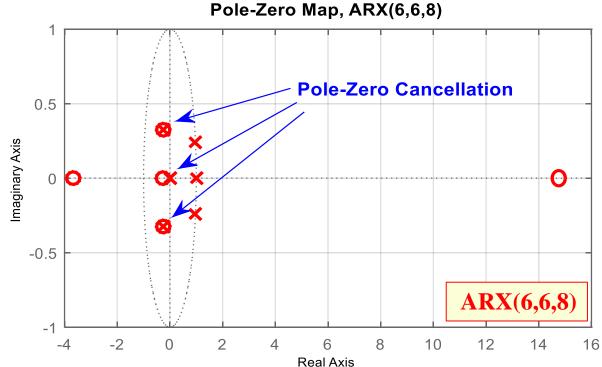
Here, we selected ARX model with two different structures. We can determine the pole-zero locations using the pzmap function in MATLAB.

$$y(k) = \frac{B(q)}{A(q)}u(k) + \frac{1}{A(q)}e(k)$$

• The results show there are pole-zero cancellation in ARX(6,6,8) structure. It means the model is **over-parameterized** and it is **unnecessarily complicated**, which makes the model **sensitive to parameter variations**.

Over-Parameterized Model





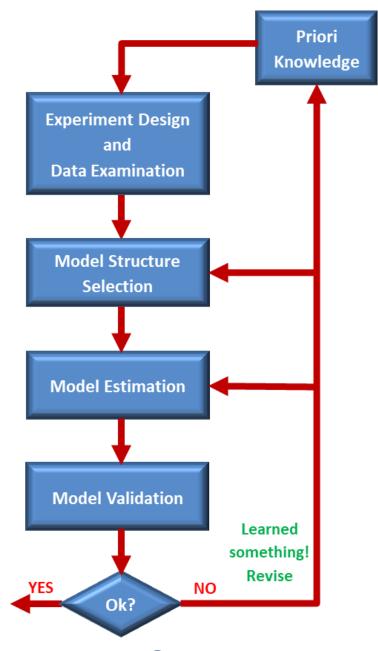
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 - Simulation & Cross Validation
 - Prediction Error Method
 - Model Validity Criteria
 - Parameters Confidence Intervals
 - Akaike's Final Prediction Error (FPE)
 - Mean-squared Error (MSE) → Loss Function
 - Pole-Zero Plots



- Residual Analysis
 - Whiteness Test
 - Independency Test



Accept the model

Residual Analysis

- Residual analysis is one of the powerful model validation methods, specifically when estimation is performed by Prediction Error Method.
- Recall the Prediction Error Method (PEM), the prediction error or residuals are determined as below

Prediction Error
$$\rightarrow \varepsilon(k) = y(k) - \hat{y}(k|k-1)$$

- Residuals are the leftovers from the modeling process, it means the part of the data that the model could not reproduce.
- Ideally and based on the definition of the Optimal Predictor, if the model is accurately describing the observed data, then the Prediction Error or Residuals, $\varepsilon(k)$, should be
 - White noise sequence with zero mean and variance of σ_e^2
 - **Uncorrelated** (independent) with the input data
- If this is not the case, then, for example, the model order, the model structure, the length of the data sequence, or the SNR level are inappropriate.
- The SNR level can be adjusted by changing the amplitude of the input signal.

Residual Analysis

Based on this fact, there are two model validation techniques by Residual Analysis

$$\varepsilon(\mathbf{k}) = \mathbf{y}(\mathbf{k}) - \widehat{\mathbf{y}}(\mathbf{k}|\mathbf{k} - 1)$$



- Under the assumption that the residuals $\varepsilon(k)$ is a white noise sequence with zero mean and variance of σ_e^2 , then we can conduct the following test to check the Whiteness
- Normality Test → Visual Check
- Independency between Residuals and Past Input Data
 - Under the assumption that the residuals $\varepsilon(k)$ are uncorrelated with past inputs u(k), then we can conduct the following test to check the Independency
 - Normality Test → Visual Check
- Fail in Whiteness Test means the residuals are not white noise. It means the noise model H(q) is incorrect
- Fail in Independency Test means the residuals are correlated with the input data. It means the system model G(q) model is incorrect.

• To test the Whiteness of the residuals $\varepsilon(k)$, we compute the Auto-Correlation Function (ACF) of the residuals

ACF of Residuals
$$\rightarrow$$
 $R_{\varepsilon}(\tau) = E[\varepsilon(k)\varepsilon(k-\tau)]$

• Theoretically, if $\varepsilon(k)$ is a White noise sequence with zero mean, then

$$\begin{cases} R_{\varepsilon}(\tau) = 0 & \text{for } \tau \neq 0 \\ R_{\varepsilon}(\tau) = \sigma_e^2 & \text{for } \tau = 0 \end{cases}$$

 $R_{\varepsilon}(au)$ σ_e^2 ACF

where σ_e^2 is the variance of the White noise.

• Practically, for a finite number of data $\{k=0,1,\cdots,N-1\}$ the ACF is estimated as below

$$\widehat{R}_{\varepsilon}(\tau) = \lim_{N \to \infty} \frac{1}{N} \sum_{k=0}^{N-1} \varepsilon(k) \varepsilon(k-\tau), \qquad |\tau| \le N-1$$

• In this case, if $\varepsilon(k)$ is a White noise sequence, then the estimated ACF values are small values for all $\tau \neq 0$ but will never be all zero.

$$\begin{cases} \widehat{R}_{\varepsilon}(\tau) & \to & 0 \quad \text{for} \quad \tau \neq 0 \\ \widehat{R}_{\varepsilon}(\tau) & \to & \sigma_e^2 \quad \text{for} \quad \tau = 0 \end{cases} \text{ as } N \to \infty$$

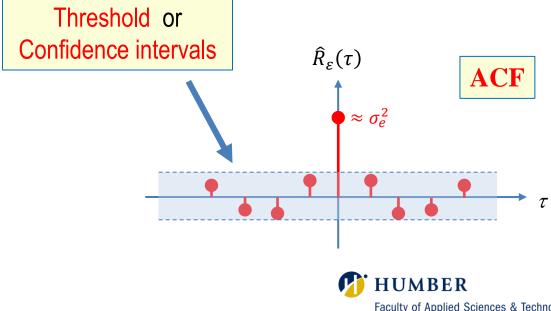
 $\hat{R}_{\varepsilon}(\tau)$ $\approx \sigma_e^2$ τ HUMBER

What does small mean in numerical context?

- According to the Whiteness Test Criteria if the ACF values are smaller than the threshold value, it means inside the confidence intervals, we can assume that the residuals are small enough to be considered as white noise sequence.
- Here, we have to define a threshold value or confidence intervals, but how?
- If we know the statistical distribution of the $\hat{R}_{\varepsilon}(\tau)$, then we can compute a confidence interval with the given probability for $\hat{R}_{\varepsilon}(\tau)$.

$$\widehat{R}_{\varepsilon}(\tau) = \lim_{N \to \infty} \frac{1}{N} \sum_{k=0}^{N-1} \varepsilon(k) \varepsilon(k-\tau), \qquad |\tau| \leq N-1$$

Based on the Central Limit Theorem, we can show that the Normalized ACF Estimates will be asymptotically Standard Normal distributed as $N \to \infty$

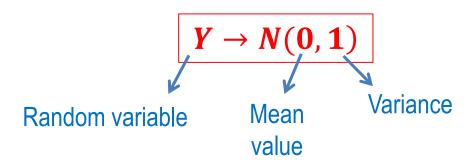


□ Central Limit Theorem

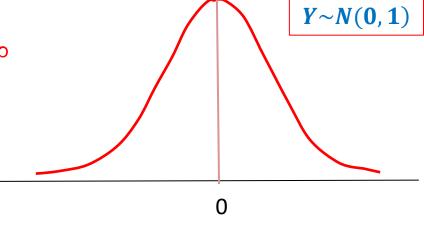
- The Central Limit Theorem states that a large sum of independent random variables with finite variance tends to behave like a Normal random variable.
- Suppose that X_1, X_2, \dots, X_N are a sequence of
 - Independent, identically distributed (i.i.d.) random variables
 - Mean value $\rightarrow \mu$
 - Variance $\rightarrow \sigma^2$
- Then the distribution of random variable Y

$$Y = \frac{X_1 + X_2 + \dots + X_N - N\mu}{\sigma\sqrt{N}} = \frac{\sum_{i=1}^N X_i - N\mu}{\sigma\sqrt{N}}$$

tends to be Standard Normal Distribution (zero mean and unit variance) as $N \to \infty$



Standard Normal Distribution



- Assume that the residuals $\varepsilon(k)$ is a white noise sequence with zero mean and variance of σ_e^2
- Then from the Central Limit Theorem, the Normalized ACF Estimates will be asymptotically Standard Normal distributed as $N \to \infty$
 - □ Proof:

$$Y = \frac{\sum_{k=0}^{N-1} \varepsilon(k) \varepsilon(k-\tau) - N \times \mathbf{0}}{\sigma_e^2 \sqrt{N}} = \frac{\sum_{k=0}^{N-1} \varepsilon(k) \varepsilon(k-\tau)}{\sigma_e^2 \sqrt{N}} = \frac{\frac{1}{N} \sum_{k=0}^{N-1} \varepsilon(k) \varepsilon(k-\tau)}{\sigma_e^2 \sqrt{N}}$$

If $N \to \infty$ the random variable Y can be simplified as below

$$Y = \sqrt{N} \frac{\hat{R}_{\varepsilon}(\tau)}{\hat{R}_{\varepsilon}(0)} \rightarrow N(0, 1)$$

• Therefore, if the Normalized ACF Estimates satisfy the Normal Distribution characteristics the White noise assumption of the Residuals will be correct.

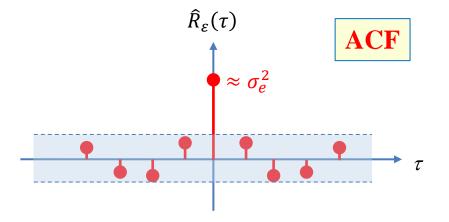
Central Limit Theorem

$$Y = \frac{\sum_{i=1}^{N} X_i - N \mu}{\sigma \sqrt{N}}$$

$$Y \rightarrow N(0,1)$$

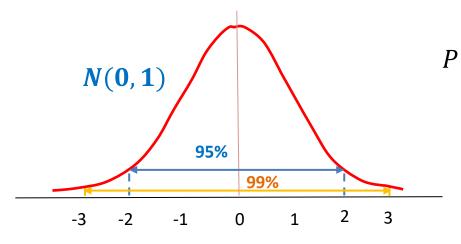
$$\widehat{R}_{\varepsilon}(\tau) = \lim_{N \to \infty} \frac{1}{N} \sum_{k=0}^{N-1} \varepsilon(k) \varepsilon(k-\tau)$$

$$\operatorname{var}(XY) = (\sigma_X^2 + \mu_X^2)(\sigma_Y^2 + \mu_Y^2) + \mu_X^2 \mu_Y^2$$



■ Normality Test

- Hypothesis: The residuals $\varepsilon(k)$ is a white noise sequence
- Plot the Normalized ACF Estimates of the residuals
- Calculate and draw the 99% or the 95% confidence intervals of the Normalized ACF Estimates
- The Normality test is passed with the confidence level of β (0.99 or 0.95) if the following condition is satisfied for each residual individually.

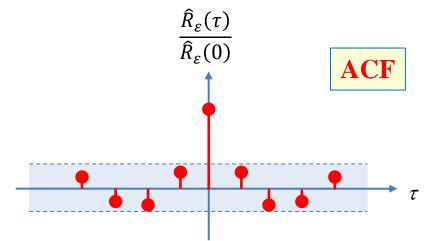


 $P\left(\sqrt{N}\left|\frac{\hat{R}_{\varepsilon}(\tau)}{\hat{R}_{\varepsilon}(0)}\right| \le N_{\beta}\right) = \beta$



$$\left| \frac{\hat{R}_{\varepsilon}(\tau)}{\hat{R}_{\varepsilon}(0)} \right| \le \frac{N_{\beta}}{\sqrt{N}}$$

- Visually check if all Normalized ACF Estimates for $\tau \neq 0$ are located inside the selected confidence interval.
- If the ACF passes the Normality Test, then the hypothesis of White noise assumption of the Residuals will be correct.



Residual Analysis

Based on this fact, there are two model validation techniques by Residual Analysis

$$\varepsilon(\mathbf{k}) = \mathbf{y}(\mathbf{k}) - \widehat{\mathbf{y}}(\mathbf{k}|\mathbf{k} - 1)$$

- Whiteness Test of Residuals
 - Under the assumption that the residuals $\varepsilon(k)$ is a white noise sequence with zero mean and variance of σ_e^2 , then we can conduct the following test to check the Whiteness
 - Normality Test \rightarrow Visual Check
- Independency between Residuals and Past Input Data
 - Under the assumption that the residuals $\varepsilon(k)$ are uncorrelated with past inputs u(k), then we can conduct the following test to check the Independency
 - Normality Test → Visual Check
 - Fail in Whiteness Test means the residuals are not white noise. It means the noise model H(q) is incorrect
 - Fail in Independency Test means the residuals are correlated with the input data. It means the system model G(q) model is incorrect.

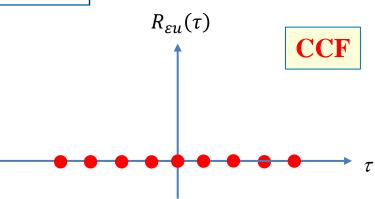
Independency Test between Residuals and Input Data

• To test the Correlation between residuals $\varepsilon(k)$ and the past input data u(k), we compute the Cross-Correlation Function (CCF)

CCF between Residuals and Input Data $\rightarrow R_{\varepsilon u}(\tau) = E[\varepsilon(k)u(k-\tau)]$

• Theoretically, If $\varepsilon(k)$ and u(k) are independent, then

$$R_{su}(\tau) = 0$$
 for all τ



• Practically, for a finite number of data $\{k=0,1,\cdots,N-1\}$ the CCF is estimated as below

$$\widehat{R}_{\varepsilon u}(\tau) = \lim_{N \to \infty} \frac{1}{N} \sum_{k=1}^{N} \varepsilon(k) u(k - \tau), \quad all \, \tau$$

• In this case, if $\varepsilon(k)$ and u(k) are independent, then the estimated CCF values are small values for all τ but will never be all zero.

$$\hat{R}_{\varepsilon u}(\tau) \to 0$$
 for all τ as $N \to \infty$

 $\hat{R}_{\varepsilon u}(\tau)$ CCF

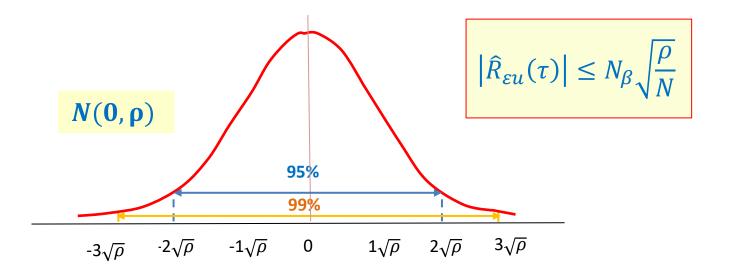
HUMBER

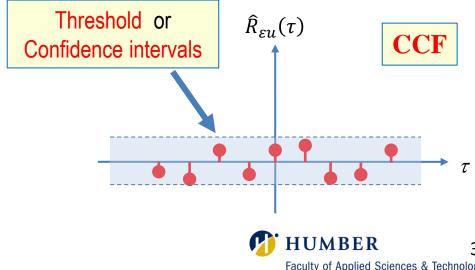
Independency Test between Residuals and Input Data

- According to the Independence Test Criteria if the CCF values are smaller than the threshold value, it means inside the confidence intervals, we can assume that the residuals are uncorrelated with past inputs.
- Assume that the residuals $\varepsilon(k)$ and the past input data u(k) are uncorrelated.
- Based on the Central limit Theorem, the Normalized CCF Estimates are asymptotically Gaussian distributed as $N \to \infty$

If
$$N \to \infty$$
 then $\sqrt{N} \hat{R}_{\varepsilon u}(\tau) \to N(0,\rho)$ ess test, here we have to check whether the

Similar to the Whiteness test, here we have to check whether the following condition is satisfied for the selected Confidence level of β (0.99 or 0.95).





Independency Test between Residuals and Input Data

■ Normality Test

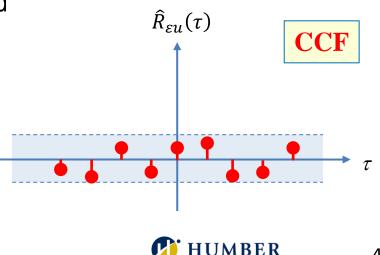
• Hypothesis: The residuals $\varepsilon(k)$ is and the past input data u(k) are uncorrelated.

$$\hat{R}_{\varepsilon u}(\tau) \approx 0$$
 for all τ

- Plot the Normalized CCF Estimates of the residuals and the past input data
- Calculate and draw the 99% or the 95% confidence intervals of the Normalized CCF Estimates
- The Normality test is passed with the confidence level of β (0.99 or 0.95) if the following condition is satisfied

$$\left|\widehat{R}_{\varepsilon u}(\tau)\right| \leq N_{\beta} \sqrt{\frac{\rho}{N}}$$

- Visually check if all Normalized CCF Estimates for all τ are located inside the selected confidence interval or not.
- If the CCF passes the Normality Test, then the hypothesis of Independency assumption of the Residuals and the Past Input Data will be correct.



Residual Analysis

■ MATLAB Function for Residual Analysis

• In System Identification Toolbox MATLAB, we have the following function to compute and test the residuals for Normality

resid(data, sys)

Variable	Description
data	Input-output data in iddata format
sys	Identified model (ARX, ARMAX, OE, BJ)

- The resid function computes the one-step ahead prediction errors (residuals) for the identified model and plots the Normalized Auto-Correlation Function (ACF) of the residuals and the Normalized Cross-Correlation Function (CCF) of the residuals with the input signal for lags from -25 to 25.
- The 99% confidence interval has also been displayed as a shaded region around the x-axis.

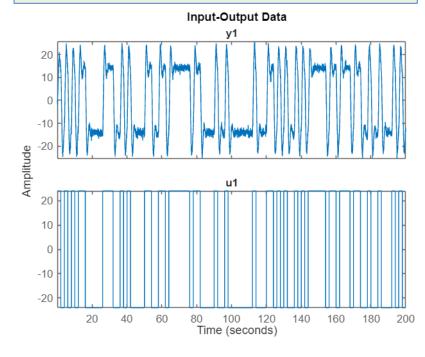


This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 1: Collect and Examine the I/O Data

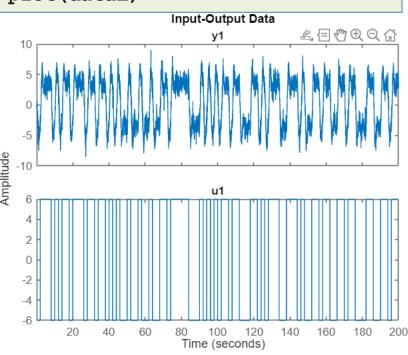
High SNR Dataset

Ts = 0.05; dataH = iddata(yH,uH,Ts); plot(dataH)



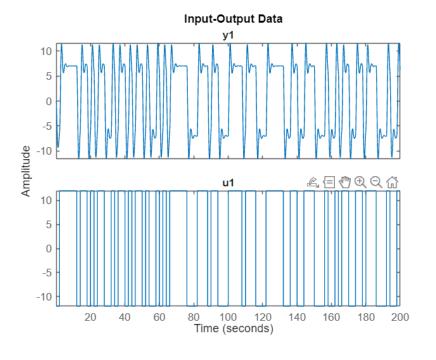
Low SNR Dataset

```
Ts = 0.05;
dataL = iddata(yL,uL,Ts);
plot(dataL)
```



Noise-free Dataset

```
Ts = 0.05;
data = iddata(y,u,Ts);
plot(data)
```



Since the sample time is 0.05sec, we collected data for 200sec, which means the total number of samples is 200/0.05=4000 samples.

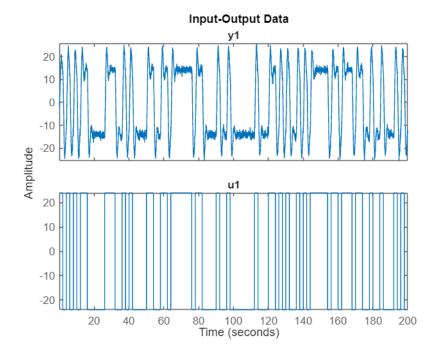


This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 2: Split the I/O Data to the Identification Data and Validation Data

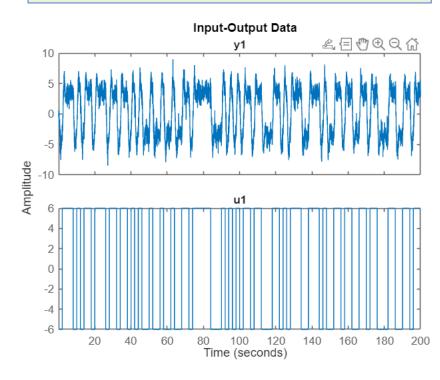
High SNR Dataset

```
dataHi = dataH(1:3000);
dataHv = dataH(3001:end);
```



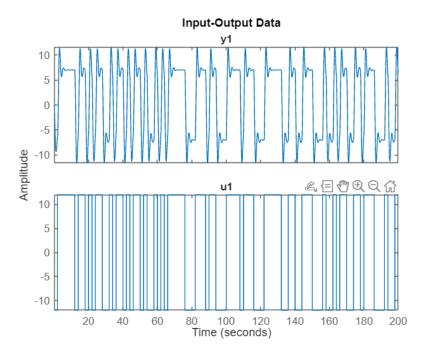
Low SNR Dataset

```
dataLi = dataL(1:3000);
dataLv = dataL(3001:end);
```



Noise-free Dataset

```
datai = data(1:3000);
datav = data(3001:end);
```



Here, we considered the first 3000 samples for identification and the last 1000 samples for validation.





This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 3: Order Selection & Delay Estimation

High SNR Dataset

Red: Default Choice (2)

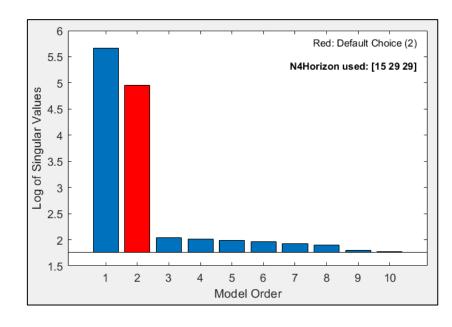
N4Horizon used: [15 32 32]

n4sid(dataH,1:10);

of Singular Values

Low SNR Dataset

n4sid(dataL,1:10);



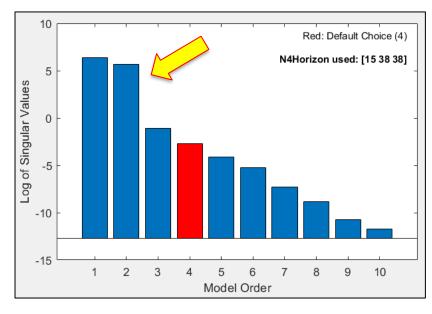
Selected order = 2

Model Order

Selected order = 2

Noise-free Dataset

n4sid(data,1:10);



Recommended order = 4 (Possibility of the second-order model)

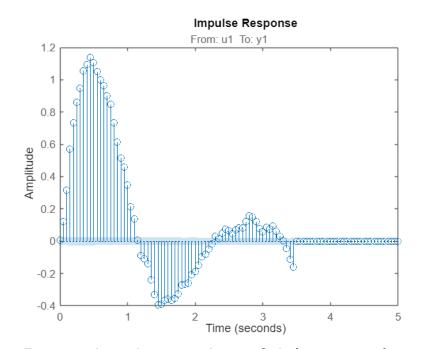


This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 3: Order Selection & Delay Estimation

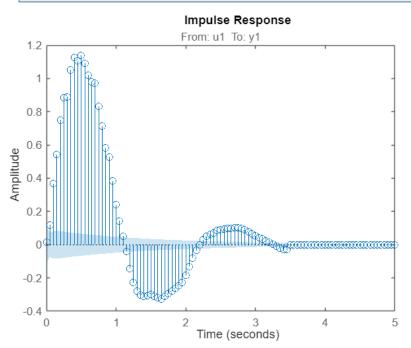
High SNR Dataset

ir = impulseest(dataH); ir_plot = impulseplot(ir); showConfidence(ir_plot,1)



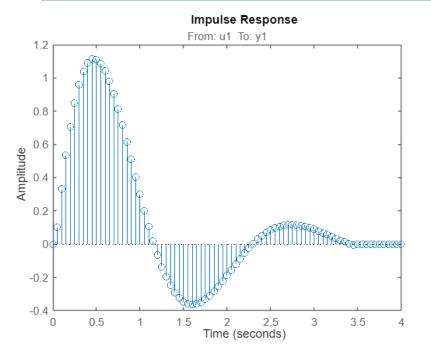
Low SNR Dataset

```
ir = impulseest(dataL);
ir_plot = impulseplot(ir);
showConfidence(ir_plot,1)
```



Noise-free Dataset

```
ir = impulseest(data);
ir_plot = impulseplot(ir);
showConfidence(ir_plot,1)
```



Determine the number of delay samples n_k from the estimated impulse response samples.

Note that there is always one delay sample due to the ZOH.

Therefore, there is no delay time in this system.

$$t_d = T_s(n_k - 1)$$



This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 4: Select the Model Structure & Identify the Transfer Function Model

High SNR Dataset

```
np = 2;
nz = 0;
sys1 = tfest(dataHi,np,nz,0)
```

Second-order model with no zero.

$$G_1(s) = \frac{5.004}{s^2 + 1.957s + 8.447}$$



This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 5: Model Validation

1- Model validation criteria

```
present(dataHi)
```

```
sys1 =

5.004 (+/- 0.01944)

s^2 + 1.957 (+/- 0.009539) s + 8.447 (+/- 0.02627)

Fit to estimation data: 93.46%

FPE: 0.9967, MSE: 0.9934
```

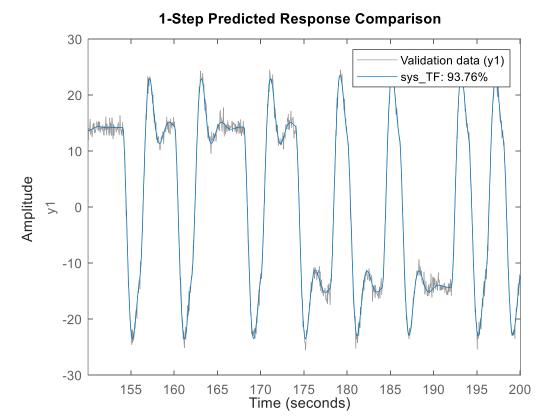
- Confidence intervals of the estimation → Must be small
- Fit to estimation data → Between 70% to 100% depends on the SNR
- Mean Square Error (MSE) → Must be small enough (less than 1)
- Final Prediction Error (FPE) → Must be small enough (less than 1)

High SNR Dataset

2 - Cross-validation

compare(dataHv,sys1,1)

Validate the identify model based on the validation dataset.



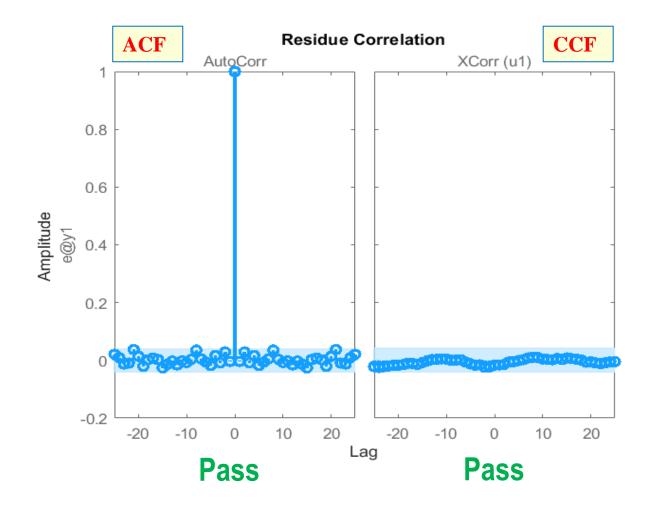


This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 5: Model Validation

3- Residual Analysis

resid(sys1,dataH)



High SNR Dataset

- Visually check the Normality test for:
 - Whiteness of the residuals
 - Independency of the residuals from input data
- Both ACF and CCF must pass the Normality test.
- If it failed, check for
 - the model order,
 - the model structure,
 - the length of the data sequence,
 - the SNR level (input amplitude), Usually, ACF fails.

Note: Sometimes the ACF might fail the Whiteness test due to high SNR data. In that case decreasing the input amplitude and collecting more noisy data will be helpful.

Usually, CCF fails,



This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 6: Check the pole/zero locations & DC-gain for G(s)

High SNR Dataset

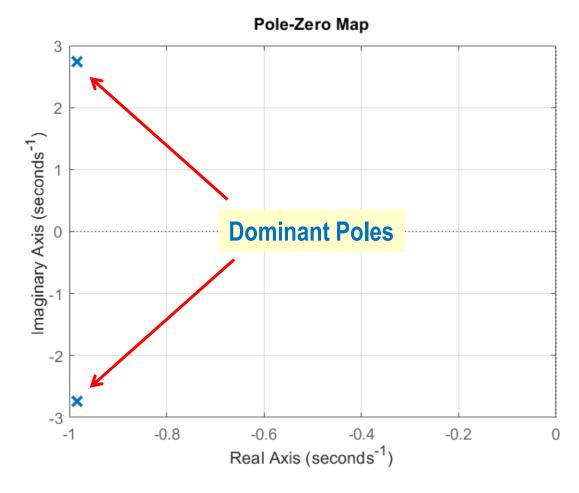
Second-order model with no zero.

$$G_1(s) = \frac{5.004}{s^2 + 1.957s + 8.447}$$

pzmap(sys1) pole(sys1)

Poles: $-0.9785 \pm j2.7367$

DC-gain: $\lim_{s \to 0} G(s) = \frac{5.004}{8.447} = 0.592$





This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 7: Check the Step Response and Time-domain Specifications

High SNR Dataset

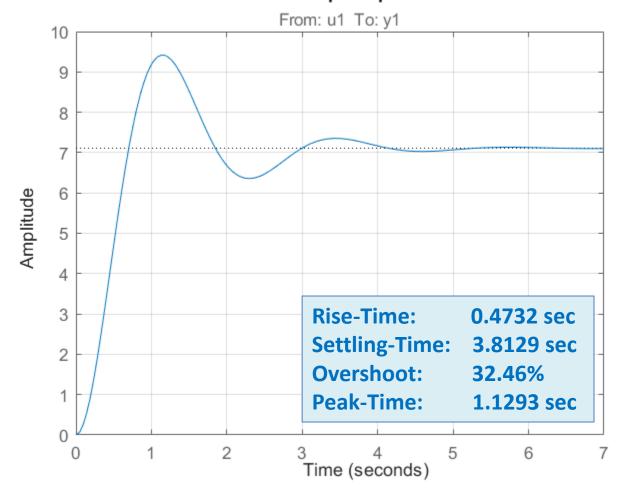
Second-order model with no zero.

$$G_1(s) = \frac{5.004}{s^2 + 1.957s + 8.447}$$

```
opt = RespConfig;
opt.Amplitude = 12;
stepplot(sys1,opt)
stepinfo(sys1)
```

```
ans =
         RiseTime: 0.4732
    TransientTime: 3.8129
     SettlingTime: 3.8129
      SettlingMin: 0.5298
      SettlingMax: 0.7847
        Overshoot: 32.4649
       Undershoot: 0
             Peak: 0.7847
         PeakTime: 1.1293
```

Step Response





This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 3: Order Selection & Delay Estimation

High SNR Dataset

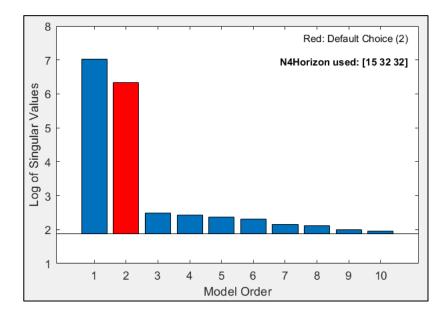
n4sid(dataH,1:10);

Low SNR Dataset

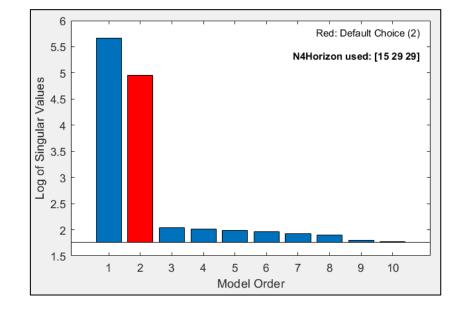
n4sid(dataL,1:10);

Noise-free Dataset

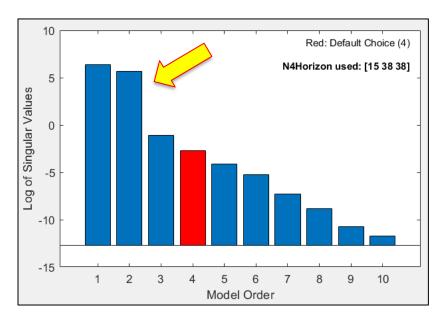
n4sid(data,1:10);



Selected order = 2



Selected order = 2



Recommended order = 4 (Possibility of the second-order model)



This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 4: Select the Model Structure & Identify the Transfer Function Model

Low SNR Dataset

Second-order model with no zero.

```
np = 2;
nz = 0;
sys2 = tfest(dataLi,np,nz,0)
```

Third-order model with two zeros.

```
np = 3;
nz = 2;
sys32 = tfest(dataLi,np,nz,0)
```



This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 5: Model Validation

1- Model validation criteria

present(dataLi)

Second-order model with no zero.

Third-order model with two zeros.





This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

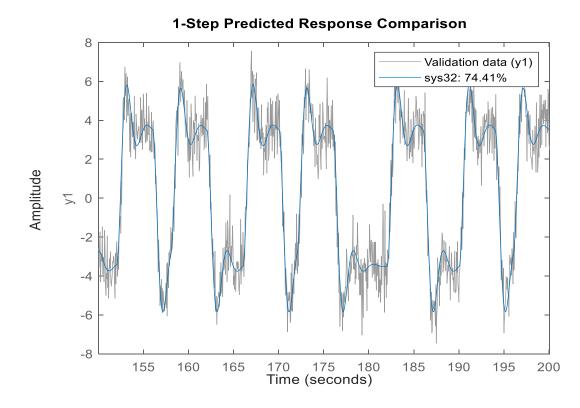
Step 5: Model Validation

Low SNR Dataset

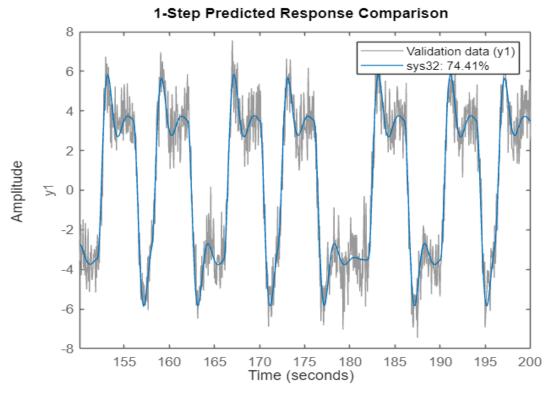
2- Cross-Validation

compare (dataLv, sys2,1)

Second-order model with no zero.



Third-order model with two zeros.



The cross-validation results are almost similar for both models.



This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

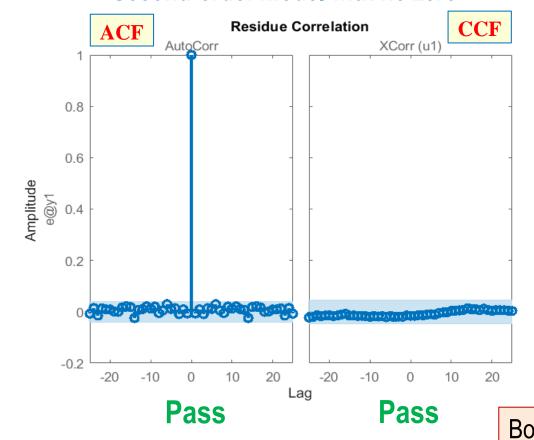
Step 5: Model Validation

Low SNR Dataset

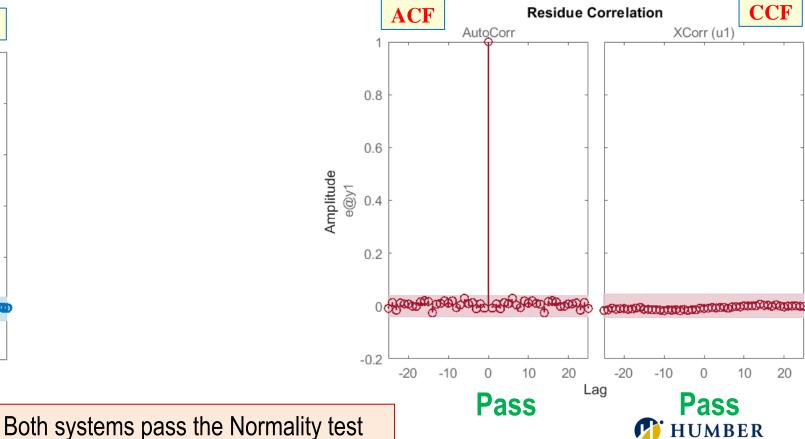
3- Residual Analysis

resid(sys1,dataL)

Second-order model with no zero.



Third-order model with two zeros.



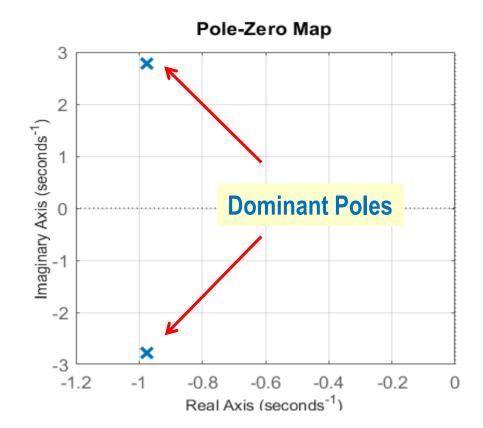


This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 6: Check the pole/zero locations & DC-gain for G(s)

Low SNR Dataset

Second-order model with no zero.



Poles

$$-0.9706 \pm j2.8072$$

 -0.0156

Zeros:

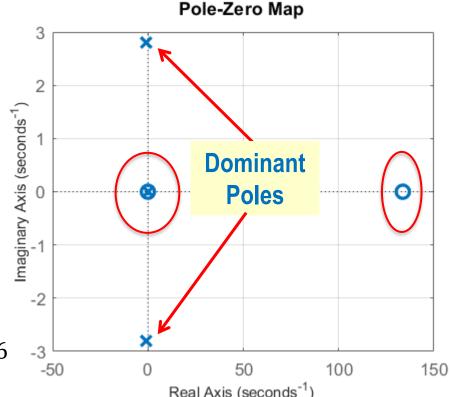
+133.6775

-0.0157

DC-gain:

$$\lim_{s \to 0} G(s) = \frac{0.08048}{0.1374} = 0.586$$

Third-order model with two zeros.



Poles: $-0.9755 \pm j2.7853$

DC-gain: $\lim_{s \to 0} G(s) = \frac{5.069}{8.71} = 0.582$

Since there are pole-zero cancellation and one single zero is too far from the dominant poles, the third-order system is over-parameterized. It can be approximated as a second-order system.



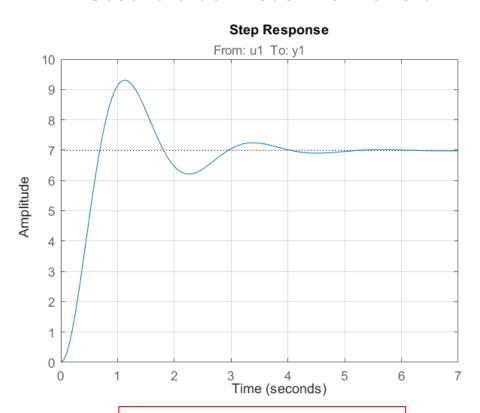


This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 6: Check the pole/zero locations & DC-gain for G(s)

Low SNR Dataset

Second-order model with no zero.



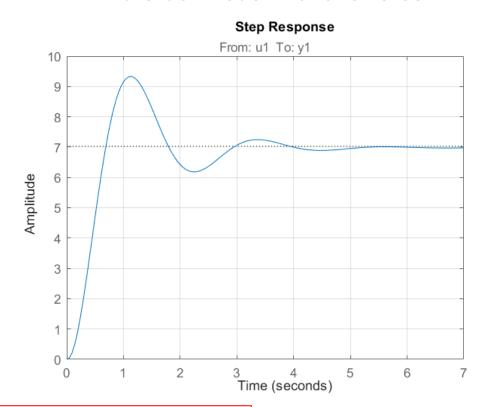
Rise-Time: 0.4630 sec

Settling-Time: 3.7670 sec

Overshoot: 33.27%

Peak-Time: 1.1330 sec

Third-order model with two zeros.



Rise-Time: 0.4618 sec

Settling-Time: 4.5325 sec

Overshoot: 32.70%

Peak-Time: 1.1387 sec



This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 3: Order Selection & Delay Estimation

High SNR Dataset

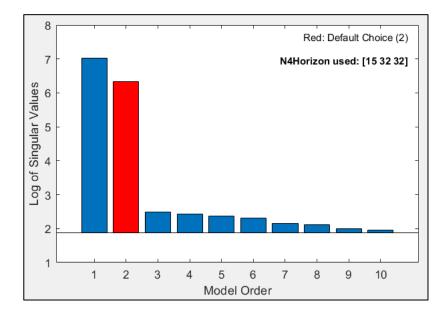
n4sid(dataH,1:10);

Low SNR Dataset

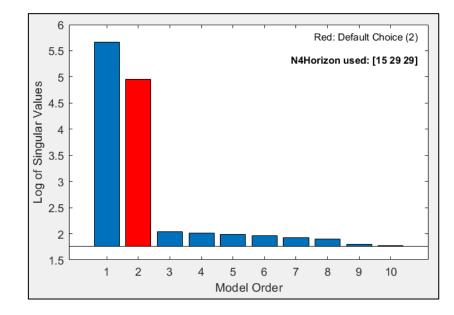
n4sid(dataL,1:10);

Noise-free Dataset

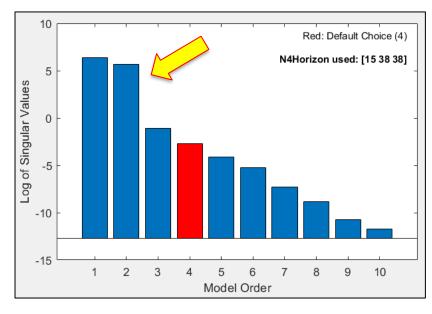
n4sid(data,1:10);



Selected order = 2



Selected order = 2



Recommended order = 4 (Possibility of the second-order model)



This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 4: Select the Model Structure & Identify the Transfer Function Model

Noise-free Dataset

Fourth-order model with three zeros.

```
np = 4;
nz = 3;
sys4 = tfest(datai,np,nz,0)
```

$$G_4(s) = \frac{-0.01879s^3 + 4.789s^2 + 82.79s + 77}{s^4 + 18.28s^3 + 56.22s^2 + 171.7s + 131.5}$$

Second-order model with no zero.

$$G_5(s) = \frac{5.052}{s^2 + 1.981s + 8.622}$$



This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

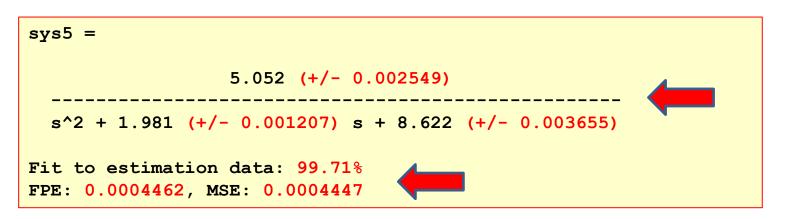
Step 5: Model Validation (Model Validity Criteria)

Noise-free Dataset

```
present(datai)
```

Fourth-order model with three zeros.

Second-order model with no zeros.



- The fit percent, FPE and MSE are all in good range for both models.
- However, the fourth-order model has large confidence intervals.

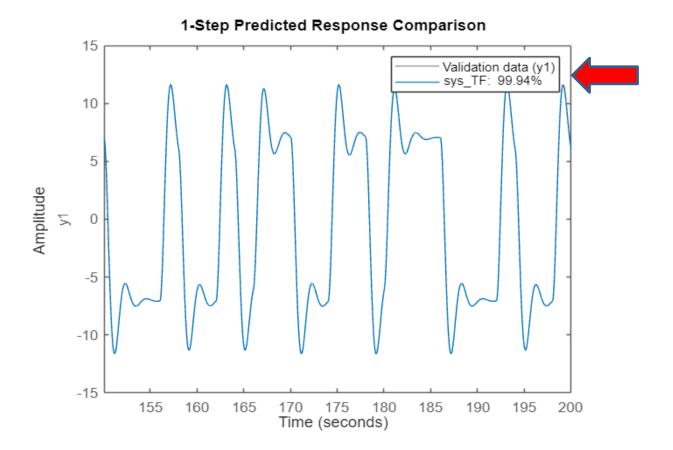


This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 5: Model Validation (Cross-Validation)

Fourth-order model with three zeros.

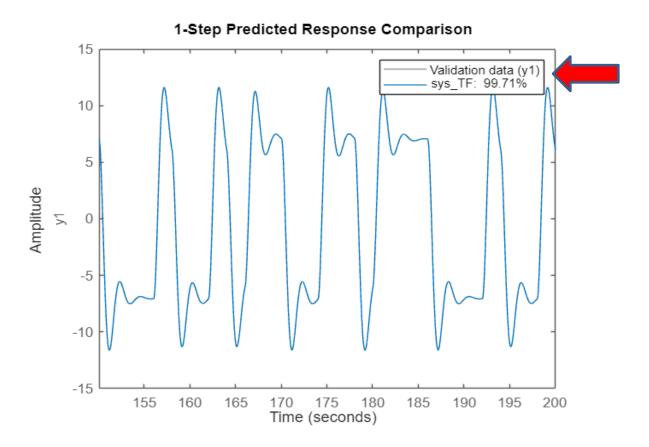
compare(datav,sys4,1)



Noise-free Dataset

Second-order model with one zero.

compare (datav, sys5, 1)





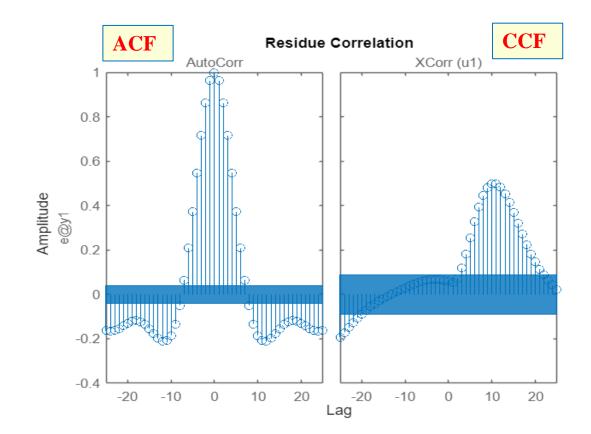
This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 5: Model Validation (Residual Analysis)

Noise-free Dataset

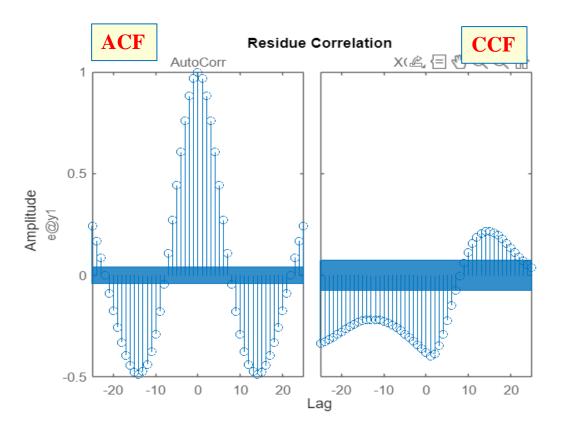
Fourth-order model with three zeros.

resid(sys4,data)



Second-order model with no zero.

resid(sys5,data)



Residual analysis is not applicable for noise-free dataset.



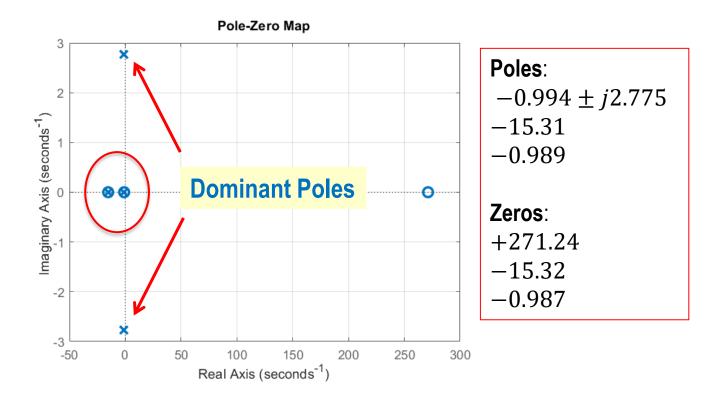


This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

Step 6: Check the pole/zero locations

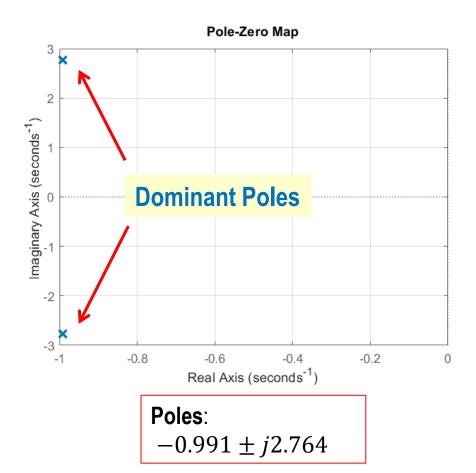
Noise-free Dataset

Fourth-order model with three zeros.



Pole-zero cancellation represents an **over-parametrized** model. The fourth-order model can be approximated as a **second-order** model based on the **dominant** poles.

Second-order model with no zero.



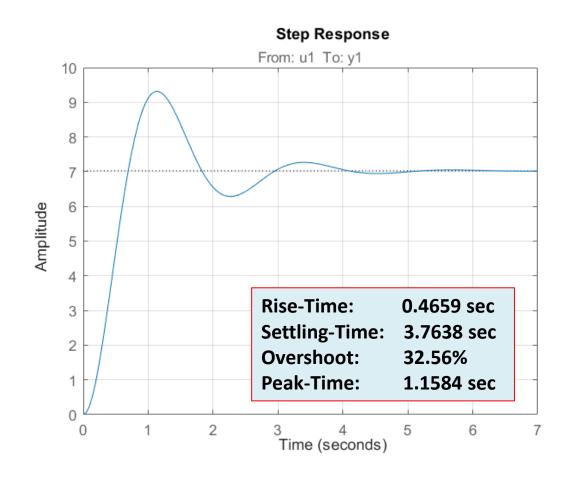


This example shows how to identify and validate a CT transfer function model from input-output data, and effect of SNR on the quality of the estimated model.

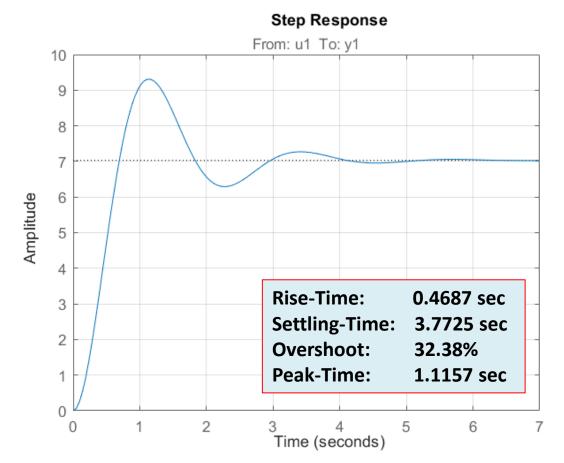
Step 7: Check the Step Response and Time-domain Specifications

Noise-free Dataset

Fourth-order model with three zeros.



Second-order model with no zero.



THANK YOU



